The background of the slide is a microscopic image showing a light-colored, textured surface (likely a Hamamatsu MPPC) covered with numerous small, dark, spherical nanoparticles. The nanoparticles are distributed across the surface, with a higher concentration on the left side where they appear as a dense, dark cluster. The overall appearance is that of a thin layer of particles on a substrate.

First Tests of Si Nanoparticle Coatings on Hamamatsu MPPCs

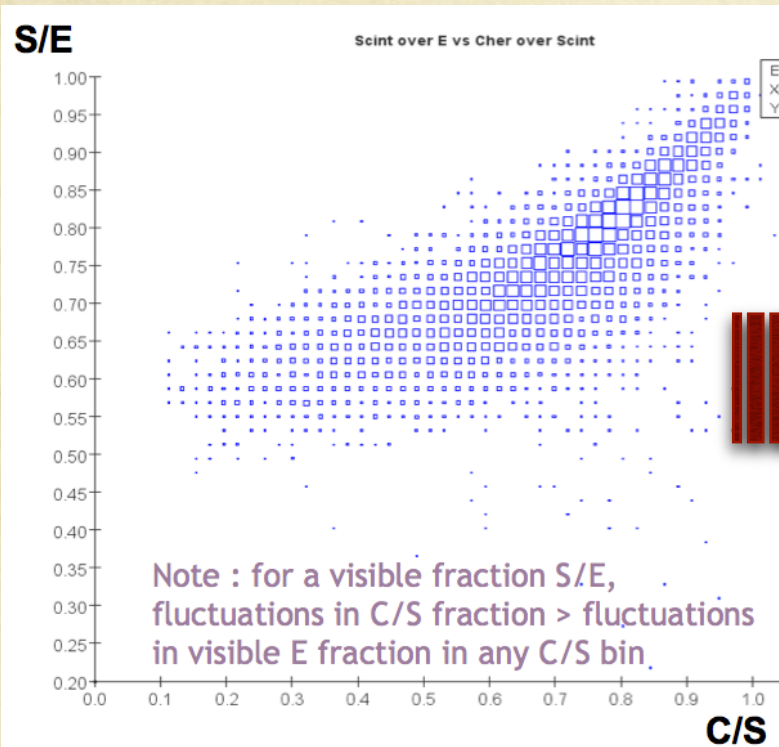
S. R. Magill

Argonne National Laboratory

Motivation

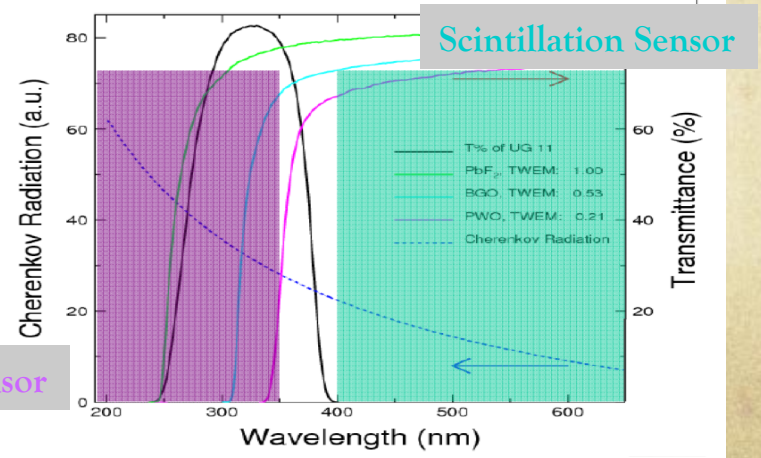
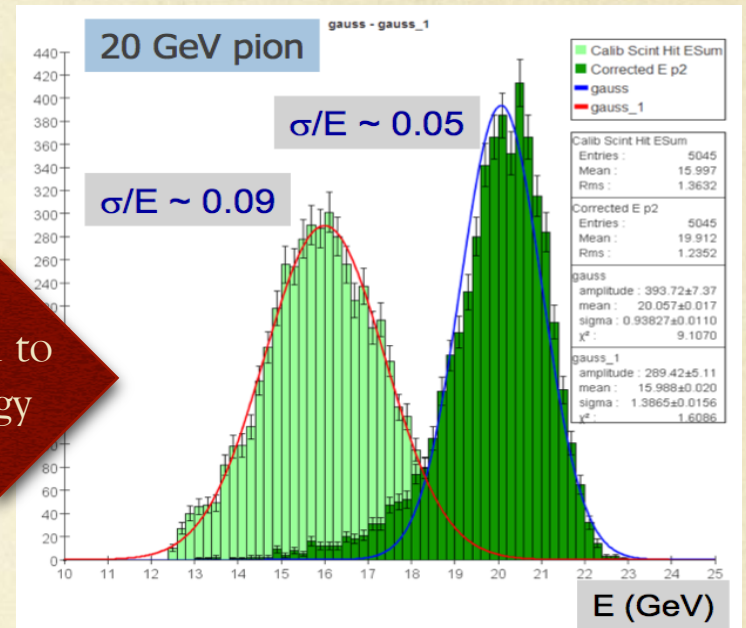
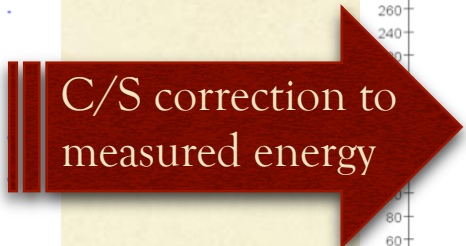
- Need for a **thin** UV photosensor to read out Cerenkov light from a clear, dense crystal in a dual-readout homogeneous hadron calorimeter (proposed for future e^+e^- collider)(DOE Advanced Collider Detector R&D)
- Observation (M. Nayfeh, et al. at U of Illinois) that Si nanoparticles act as waveshifters, absorbing light in the UV range and re-emitting it as visible light
- Proposed a test of this property - measuring the response of a standard SiPM device to low wavelength light through a film coated with Si nanoparticles

Dual-Readout Homogeneous Hadron Calorimeter R&D



Note : for a visible fraction S/E, fluctuations in C/S fraction > fluctuations in visible E fraction in any C/S bin.

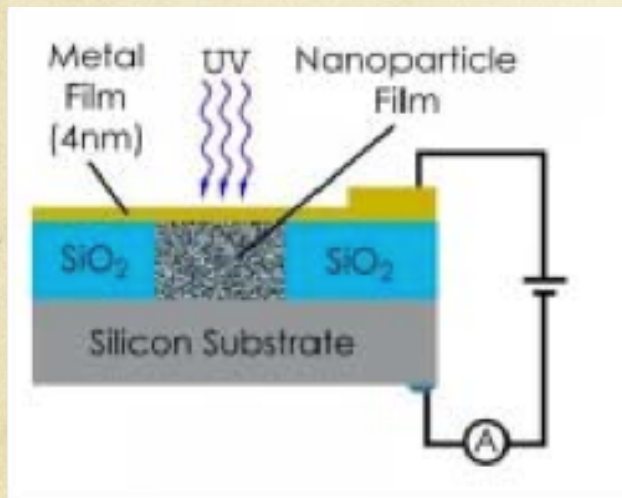
S (e calibrated scintillator response)
 -> em and had visible energy
 C (e calibrated cerenkov response)
 -> ~em part of shower
 C/S ~ em fraction of visible energy
 S/E = total fraction of energy seen



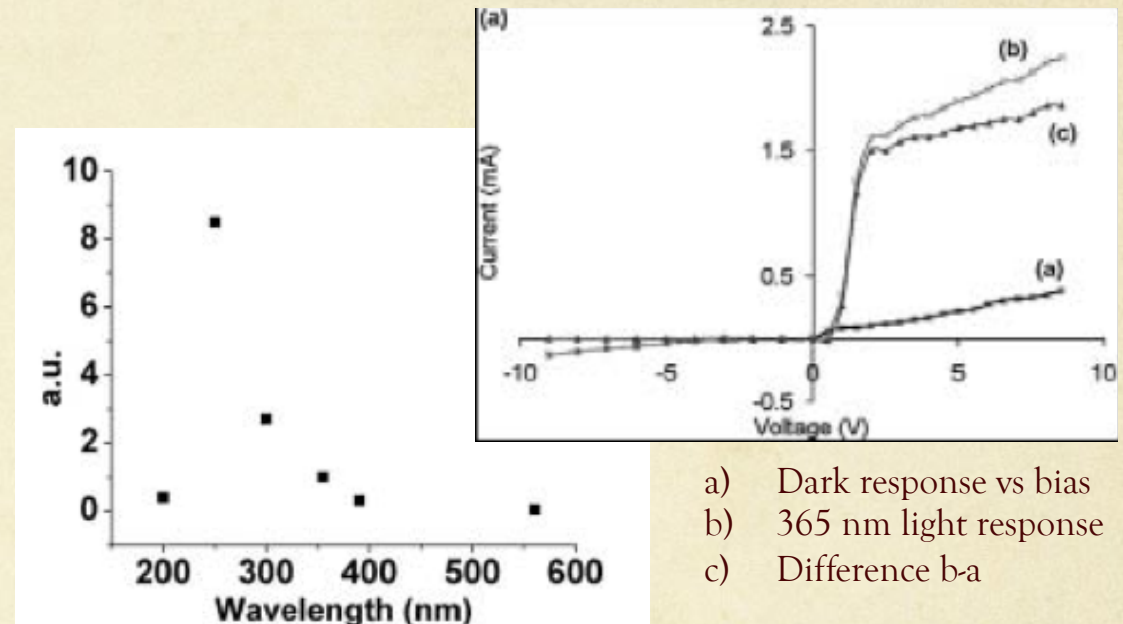
Cerenkov Sensor

Scintillation Sensor

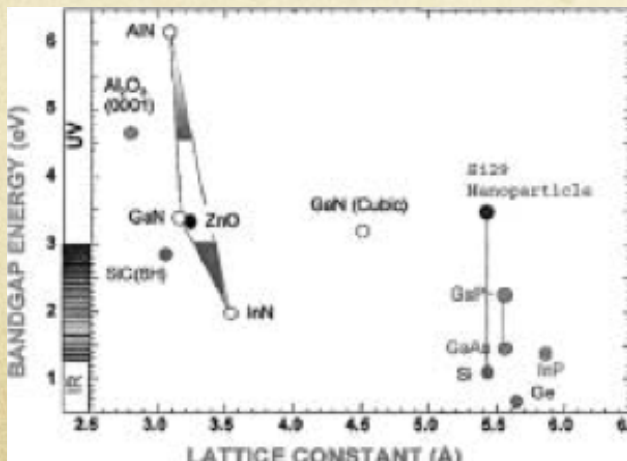
Si Nanoparticle UV Sensor



Nanoparticle photodiode



- a) Dark response vs bias
- b) 365 nm light response
- c) Difference b-a



Normal Si has a Band Gap of 1.1 eV \rightarrow 1100 nm wavelength

Si nanoparticles increase the Band Gap to \sim 3.6 eV \rightarrow 344 nm wavelength

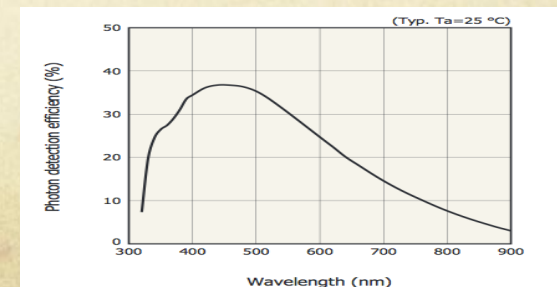
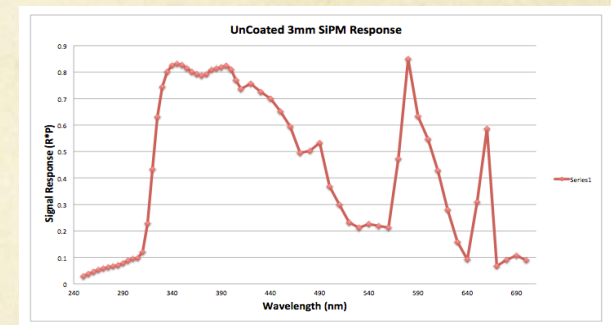
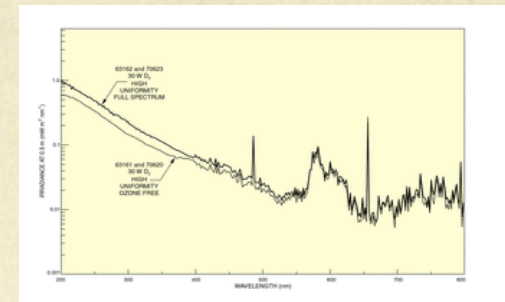
Detected UV light shifted to

\sim 650 nm (3 nm particles)

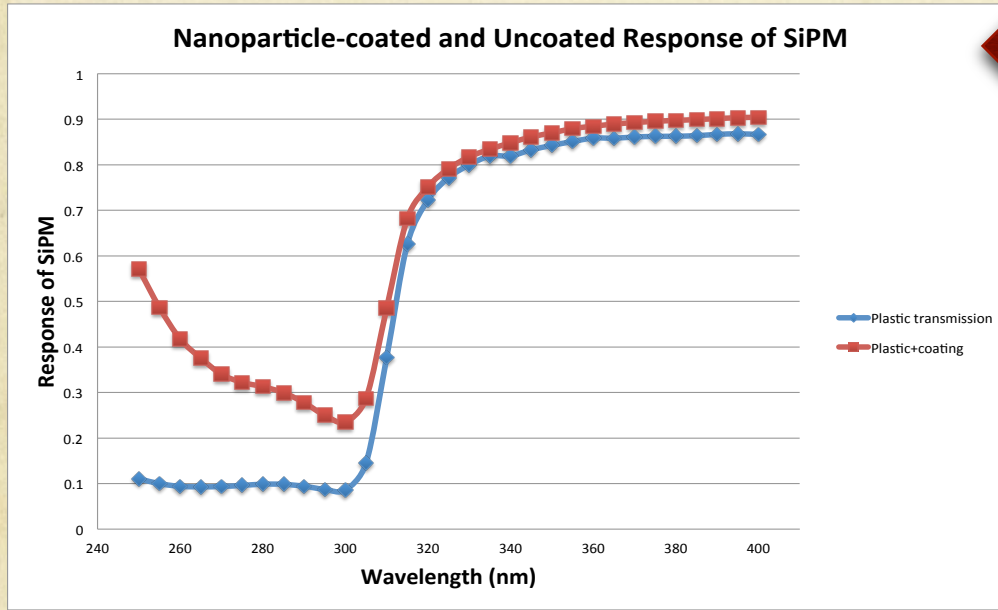
\sim 450 nm (1 nm particles)

Test Procedure

- Used a 30 Watt D₂ lamp with wavelengths >160 nm scanned through a monochromator
- Scanned in 5 nm intervals from 150 nm to 400 nm, 10 nm intervals from 400 nm to 700 nm
- Nanoparticles deposited on a thin plastic film positioned at the surface of the SiPM (3 mm X 3 mm Hamamatsu MPPC)
- Measured current through a resistor with SiPM in photovoltaic mode (no bias voltage) – amplification of $\sim 10^6$

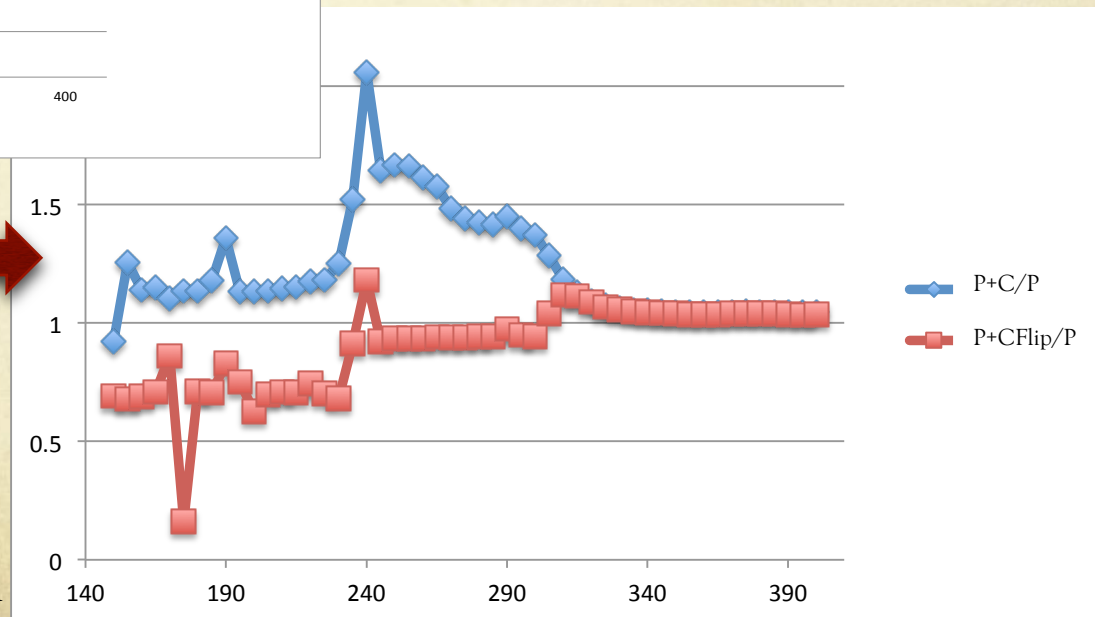


Results



SiPM response for light through plastic film only (blue)
SiPM response for plastic + nanoparticle coating (red)
Both divided by the response for no plastic film

SiPM response for nanoparticle coating + plastic film (blue)
SiPM response reverse order (red)
Both divided by the response for plastic only
Extended to lower wavelength



Summary and Future R&D

- Si nanoparticles are able to absorb UV light and re-emit it in the visible range – extending the effective low wavelength response of a standard SiPM
- Plan to continue direct coating tests on SiPMs with controlled nanoparticle thickness and size (1 nm particles -> max emission ~450 nm)
- Will measure response vs nanoparticle coating thickness -> UV response, visible blindness?
- Plan to test a photodiode using Si nanoparticles deposited on P-type Si substrate
- Will optimize for **thinness** of photosensor with an active area of ~few cm²